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Broader context

Harvesting solar energy via photocatalytic and photoelectrochemical (PEC) water-splitting technology is an emerging solution to produce cost-effective and carbon-free hydrogen and oxygen fuels for sustainable global development. Photovoltaic (PV)-biased PEC water splitting is an effective strategy for achieving a solar-to-hydrogen (STH) energy conversion efficiency of more than 10%, which is essential for commercial solar hydrogen production. To date, the reported STH energy conversion efficiency of well-recognized metal oxides or nitride photoelectrode-based PEC–PV tandem water splitting systems (lead-free and single semiconductor-electrolyte junction) is less than 7%. Considering the advancements in PV technologies, the STH energy conversion efficiency of tandem devices remains challenging owing to limited visible light absorption and inefficient utilization of photogenerated holes inside photoelectrode materials for water oxidation. Herein, we demonstrate that a polycrystalline void-free Ta₃N₅ thin-film (covered with a homogenous NiFeO_x electrocatalyst) semitransparent photoelectrode eliminates the abovementioned challenges and realizes a photocurrent of 7.4 mA cm⁻² at 1.23 V vs. a reversible hydrogen electrode under simulated AM1.5G solar illumination. The visible-light-absorbing NiFeO_x/Ta₃N₅ semitransparent photoelectrode and two-series-connected CuInSe₂ solar cells drove unbiased overall water splitting with an initial STH energy conversion efficiency of 9%. Our work represents a significant advancement in maximizing the potential of visible-light photoabsorbers and approaching the efficiency targets for practical solar hydrogen production.

crucial Ta₃N₅-thin-film parameters for further performance enhancement.

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Design of semitransparent tantalum nitride photoanode for efficient and durable solar water splitting†

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Unbiased solar water splitting via a photoelectrochemical–photovoltaic (PEC–PV) tandem device is a promising strategy for efficient, low-cost, and sustainable hydrogen production to address growing energy demands. The bandgap of Ta₃N₅ is 2.1 eV for a theoretical limit of solar-to-hydrogen (STH) energy conversion efficiency of 15.3%, but the inefficient utilization of photogenerated holes limits the STH efficiency to 7% when Ta₃N₅ is used as a single photoanode. In addition, the formation of a TaO_x insulating layer on the bare Ta₃N₅ surface caused by the self-photooxidation of the Ta₃N₅ surfaces leads to the poor stability of the water oxidation reaction. In this study, we fabricated a void-free Ta₃N₅ planar thin film, originating from metallic Ta deposition by high-power sputtering followed by nitridation in ammonia treatment at high temperature, grown on a transparent GaN/Al₂O₃ substrate. With the uniform decoration of the Ta₃N₅ surface with an ultrathin NiFeO_x electrocatalyst layer, the semitransparent Ta₃N₅ photoanode drastically improved the stability and generated a photocurrent of 7.4 mA cm^{-2} at 1.23 V vs. a reversible hydrogen electrode under simulated AM1.5G solar illumination. Unassisted water splitting by a transparent Ta_3N_5 photoanode coupled with CuInSe₂ PV was demonstrated with an initial STH efficiency of 9%, which is the highest efficiency ever reported among metal oxide/nitride-based PEC–PV tandem cells. With the homogeneous electrocatalyst, the tandem cell achieved the stabilized STH efficiency of 4% up to 2 h of device operation. Using measurements and theoretical modeling, the charge carrier kinetics and transport were determined to identify the most

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1. Introduction

The photoelectrochemical (PEC) water splitting reaction is widely recognized as one of the most promising methods for the sustainable generation of hydrogen and oxygen gases (suitable for storage and transportation) from solar energy and water. $1-5$ Typically, the PEC system is comprised of a lightabsorbing photoelectrode (defined as the working electrode (WE)), which is serially connected via electrical bias with the counter electrode (CE). The operation of a PEC system requires solar and electrical energy to maximize the solar-to-hydrogen (STH) energy conversion efficiency from overall water splitting (OWS). Despite visible-light photon absorption, the appliedbias photon-to-current efficiency (ABPE) for the oxygen evolution reaction (OER) has been restricted to 3.25% among metal oxide/nitride-based photoanodes.6,7 Between WE and CE, the Photovoltaic (PV) cells are an attractive strategy for converting sunlight to the required electrical bias for OWS. Such a PEC–PV tandem device comprises series-connected wide-bandgap and narrow-bandgap semiconducting materials at the top and bottom, respectively. During device operation, the incident AM1.5G solar spectrum is harvested up to the bandgap energy of the top semiconductor, and the rest of the transmitted spectrum is absorbed by the bottom semiconductor to generate a matched OWS current density. Consequently, the STH energy conversion efficiency of a tandem device is governed by a widebandgap semiconductor (top), which has relatively less light absorption than a narrow-bandgap semiconductor (bottom).^{8,9} The PEC–PV tandem configuration facilitates solar water splitting without any external electrical bias and is therefore considered as a promising candidate for realizing high STH energy conversion efficiency up to theoretical limits of $\sim 40\%$ ^{10–12} and 26% (see Fig. S1, ESI†) at fixed bottom narrow-bandgap semiconductor of 0.4 eV and 1.12 eV, respectively. The development of narrowbandgap photoelectrodes for visible-light absorption and efficient charge utilization is crucial and achieving a high STH energy conversion efficiency of more than 10% for commercial STH production is challenging. **Example 11. Critical control 2022.** The photoshed on 02 10 2022. The photoshed on 2022. The photoshed on 2022. The photoshed under the common access Article is likely a model of the photoshed on 2022. The photoshed on

Various materials have been designed for the cost-effective development of tandem devices to realize unassisted OWS. For instance, wide-bandgap metal oxides/nitrides such as $\mathrm{WO}_3, ^{13-15}$ BiVO₄,¹⁵⁻²⁰ Fe₂O₃,²¹⁻²³ and Ta₃N₅^{7,24-26} based photoanodes have been extensively examined for the OER. In addition, perovskite oxides $(BaSnO₃)²⁷$ and PV grade materials (like silicon) have been developed as photoanodes $28-30$ to generate the photocurrent density over 10 mA cm^{-2} at 1.23 V vs. a reversible hydrogen electrode (V_{RHE}) under AM1.5G solar illumination. The Si-based photoanode exhibited a stabilized photocurrent density of 20 mA $\rm cm^{-2}$ for 100 h of continuous operation.28–30 However, these photoanodes based on PV grade materials have a non-transparent structure, and therefore, not suitable for tandem-type unassisted OWS. Thus, the development of the visible-light-absorbing semitransparent photoanode is a prerequisite for the application of the tandem-type OWS cell. A lot of studies have attempted to develop visible-light-absorbing semitransparent photoanodes based on $Fe₂O₃$, BiVO₄, metal ferrite,

and Ta_3N_5 that can be applicable for the tandem-type PEC–PV cells.8,31 Moreover, narrow-bandgap semiconductors such as chalcogenides, $32-34$ silicon, $35,36$ dye-sensitized solar cells $(DSCs)$,^{13,14} and perovskite solar cells $(PSCs)$ ^{37–39} were employed either as photocathodes or photovoltaic cells in tandem devices for the hydrogen evolution reaction (HER). Recently, Park et al. achieved the highest reported STH of 4.49% in Ti- and Si-codoped $Fe₂O₃$ semitransparent photoanode coupled with PSC.⁴⁰ Wang et al. showed an impressive STH energy conversion efficiency of 6.5% from dual-BiVO₄ photoanodes and PSCs-based tandem device. 37 Besides, Table S1 (ESI†) presents the summary on the recent developments of PEC–PV tandem device. To achieve an STH energy conversion efficiency of 10%, the light absorption edge of the front semitransparent photoanode should be in the wavelength range of 527 nm to 946 nm at an external quantum efficiency (EQE) of 100% and narrow-bandgap energy of 1.12 eV (see Fig. S1b, ESI†).

Tantalum nitride (Ta₃N₅) with a bandgap energy of 2.1 eV is a promising candidate for absorbing solar light up to a wavelength of 600 nm with a theoretical STH energy conversion efficiency limit of 15.26% at an EQE of 100% ^{25,41-43} These light absorption features and appropriate energy level alignment with the water redox potential have prompted significant research on different Ta_3N_5 -based solar water splitting technologies such as photocatalyst sheets, Z-schemes, PEC cells, and tandem devices for water splitting activity. Wang et al. demonstrated OWS from the heterojunction of single crystalline Ta_3N_5 nanorods with KTaO₃ particles.⁴⁴ In a different study, Wang et al. displayed the potential of Ta₃N₅ (modified with Ir and CoO_x electrocatalysts) for OER with its counterpart La and Rh co-doped SrTiO₃ for HER in Z-scheme system.⁴⁵ Moreover, our group showed that the OER activity of non-transparent Ta_3N_5 nanorods (Ta₃N₅-NRs), loaded with FeNiO_x electrocatalyst, photoanode was significantly improved by suppressing fundamental loss mechanisms to realize half-cell STH (HC-STH) energy conversion efficiency of 2.7% .⁷ The onset potential of such efficient photoanode was ~ 0.57 V_{RHE}, which could be limited by the surface defect states of Ta_3N_5 .^{7,46} The onset potential of non-doped Ta_3N_5 -based photoanodes were typically reported in the range of \sim 0.5–0.8 V_{RHE}.^{8,24–26} The surface passivation (by TiO₂ and GaN)⁴⁷⁻⁴⁹ and low-valence cation (such as Zr, Mg, Sc, Ba, and B)^{6,50-54} dopant engineering of Ta₃N₅ enabled the lowering of onset potential for OER activity. Besides this, the BaTaO₂N/Ta₃N₅ heterostructure based photoanode could reduce the onset potential by selectively transferring the holes from Ta₃N₅ to electrolyte for OER activity.⁵⁴

 Ta_3N_5 material is generally processed by heating the precursor compounds (like Ta₂O₅, TaO_{δ}, and Ta metal) in an ammonia (NH₃) atmosphere at high temperature close to 1000 $\mathrm{C}^{7,26,47}$ Typically, such harsh high temperature processing deteriorated the commercially available visible-lighttransparent conductive substrates such as indium tin oxide (ITO) and fluorine-doped tin oxide (FTO) and led to low conductivity and the transparency.⁵⁵ To overcome this problem, Ta_3N_5 films were developed on the chemically durable transparent substrates such as Ta-doped TiO_2 ,⁵⁶ carbon nanotube

film-coated quartz,⁵² GaN-coated sapphire,⁵⁷ and synthetic quartz.²⁶ In addition, the Ta₃N₅ film was prepared directly on FTO substrate by using an atomic layer deposition technique, however, the light absorption in long wavelength range was limited by film thickness.⁵⁸ Recently, our group developed a Ta_3N_5 planar thin film (loaded with NiFeO_x electrocatalyst) on transparent n-type GaN-coated sapphire $(GaN/Al₂O₃)$ substrate for OER.⁵⁷ The GaN/Al₂O₃ substrate displayed excellent electrical and optical properties after the deposition of Ta_3N_5 thin film under high temperature nitridation condition. Additionally, n-type GaN layer conjugated with Ta_3N_5 acts as a hole-blocking layer to suppress electron–hole recombination, resulting in enhanced photocurrent density for OER activity.⁵⁷ The developed semitransparent Ta₃N₅/GaN/Al₂O₃ photoanode was wired with two series-connected (dual) CuInSe₂ (CIS) photovoltaic cells (integrated with Pt/Ni electrocatalyst) for HER activity. 57 This Ta_3N_5 -CIS tandem cell initially provides a STH energy conversion efficiency of 7%, which reduces to 5.5% after 15 minutes of device operation.⁵⁷ The decrease in STH energy conversion efficiency primarily originated from the performance degradation of the Ta_3N_5 photoanode. During device operation, the photogenerated holes were migrated to the $Ta₃N₅/water interface and drove the oxidation to form the thin$ layer of TaO_x at the interface.^{46,47,55,59} The insulating electrical properties of the TaO_x layer suppressed the holes transport from Ta_3N_5 to water, and hence, degraded the efficiency of OER. Surface modification with an electrocatalyst layer or/and with a protection layer is an excellent strategy to reduce the photooxidation of Ta₃N₅.⁸ For instance, Kawase et al. improved the long-term durability (with current retention of 80% after 2 hours of continuous operation) of Ta_3N_5 photoanode by coating a NiFeO_x electrocatalyst with high surface coverage.⁵⁹ Although increased OER was detected with high surface coverage by $NiFeO_x$ (amount exceeding threshold of 0.1 μ mol cm⁻²), the light transmission from a photoanode above 600 nm (light absorption edge) was significantly reduced to less than 40%,⁵⁹ indicating that the simultaneous realization of good transparency/absorption and large surface coverage by electrocatalysts remains problematic for achieving high STH energy conversion efficiency and longterm durability from tandem devices for practical STH production. Energy & Environmental Science

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In this study, we developed an efficient OWS and improved the durability of Ta_3N_5 -based tandem cells. In particular, the STH energy conversion efficiency of tandem cells has increased with the development of high-quality void-free Ta_3N_5 photoactive thin film on transparent GaN/Al₂O₃ substrate. The n-type GaN layer functions as an electron collection layer as well as hole-blocking layer to suppress the electron–hole recombination at the interface of metal contact and GaN layer. The uniform loading of the NiFeO_x electrocatalyst over the Ta₃N₅ surface stabilized the OER activity for a longer time by suppressing self-photooxidation during continuous device operation. With conventional low-input-power radio-frequency magnetron sputtering (RF-MS), the fabricated Ta_3N_5 thin film has a significant number of voids across the film thickness. These voids could act as recombination or trapping centers for photogenerated charge carriers and limit OER activity. The high kinetic

energy of the incident target atoms is required to produce a highly dense film on the substrate. $60,61$ The kinetic energy of the deposited atoms can be controlled as a function of the level of input-power of RF-MS. High-quality (void-free) Ta_3N_5 thin film was obtained using an optimized high-input-power RF-MS technique. Moreover, the distribution of the NiFe O_x electrocatalyst over the Ta_3N_5 surface was varied using drop-casting and spin-coating deposition methods.⁵⁹ Uniform and nonuniform deposition of the electrocatalyst were achieved by spin-coating and drop-casting methods, respectively. The influence of the above Ta_3N_5 and electrocatalyst processing techniques on the material, PEC, and stability features was demonstrated.

The optimized $NiFeO_x/Ta_3N_5/GaN/Al_2O_3$ photoanode prepared by high-input-power RF-MS and spin-coating processes generates photocurrent density of 7.4 mA $\rm cm^{-2}$ at 1.23 $\rm V_{RHE},$ under simulated AM1.5G solar illumination. A photocurrent gain of 1.1 mA $\rm cm^{-2}$ is realized by suppressing the void density inside the Ta_3N_5 thin film. With the drop-casting method, the photocurrent decayed rapidly to almost zero within 30 min, whereas an improved photocurrent retention of \sim 4 mA cm⁻² after 1.5 h was achieved using the spin-coating method. Furthermore, the tandem device was designed with an optimized Ta_3N_5 -based photoanode and two series-connected CuInSe₂ elements to display bias-free OWS. The developed Ta_3N_5 - $CuInSe₂$ tandem cell exhibited an initial STH energy conversion efficiency of 9.0%, which is higher than that of previously reported WO₃-, Fe₂O₃-, BiVO₄-, and Ta₃N₅-based tandem devices (Table S1 and Fig. S2, ESI†). Because the STH energy conversion efficiency of 4% up to 2 h is maintained, this work presents the critical role of homogeneous electrocatalyst coating for the enhanced durability of efficient tandem systems. Furthermore, transient absorption spectroscopy (TAS) measurements of the Ta_3N_5 thin film were performed to probe the decay kinetics of photogenerated charge carriers in the picosecond to microsecond time range. Various unreported material/device parameters and dominant loss mechanisms were determined by modelling the TAS and PEC characteristics. These Ta_3N_5 specifications are essential for developing design schemes for performance optimization and realizing STH energy conversion efficiencies beyond 10%.

2. Results and discussion

2.1. Material properties of Ta_3N_5 photoanode

The Ta₃N₅/GaN/Al₂O₃ thin-film samples fabricated using lowand high-input-power RF-MS were characterized by X-ray diffraction (XRD) and scanning transmission electron microscopy (STEM) analysis. Details of the fabrication processes and characterizations are included in the Materials and methods section of the ESI.† Fig. 1a displays the measured XRD patterns of the $Ta_3N_5/GaN/Al_2O_3$, GaN/Al_2O_3 substrate, and Ta_3N_5 powder reference (DB01-089-5200). The XRD patterns of the $Ta_3N_5/$ $GaN/Al₂O₃$ samples were comprised of crystalline phases of Ta_3N_5 and GaN/Al_2O_3 substrates. The XRD peak at 24.2° was assigned to the main (110) crystal plane of Ta₃N₅. Subnitride

impurities, such as TaN and Ta_3N_6 phases, were absent in the developed specimen. Crystalline Ta_3N_5 thin films were successfully prepared on a GaN/Al_2O_3 substrate regardless of the input RF power. The GaN/Al₂O₃ substrate shows a strong XRD peak at 34° from the (002) plane, indicating a single-crystalline GaNepitaxial film on the Al_2O_3 layer. However, the peak intensity of the Ta₃N₅ thin film was weaker than that of the GaN/Al₂O₃ substrate. The XRD patterns derived from the Ta₃N₅ thin film are consistent with the Ta_3N_5 powder reference and reported literature.⁶² These results indicate that the low- and high-inputpower RF-MS developed polycrystalline Ta_3N_5 films on the $GaN/Al₂O₃$ substrates.

Fig. 1(b) and (c) show the cross-sectional annular dark field STEM (ADF-STEM) images of the $Ta_3N_5/GaN/Al_2O_3$ samples. With low- and high-input-power RF-MS, a similar Ta_3N_5 film thickness of 800 nm was developed on the GaN/Al₂O₃ substrate. This development indicates that the apparent deposition rate of the Ta precursor growth on the substrate from high-inputpower RF-MS is comparable to that of low-input-power RF-MS. Fig. S3 in the ESI† illustrates the intermittent switching of high input RF power (from continuous sinusoidal wave to zero level) using a function-generating apparatus compared to the conventional low-input-power RF-MS. The deposition rate during high-input-power RF-MS was adjusted to make the average deposition rate over the intermittent switching comparable to that of the continuous low-input-power RF-MS, leading to a similar apparent deposition rate of the precursor, and hence, the Ta_3N_5 thickness. Moreover, the cross-sectional ADF-STEM

images (in Fig. 1b) present significant voids or pinholes from the middle to the surface region of Ta_3N_5 for low-input-power RF-MS, whereas a high-quality Ta_3N_5 film without any pinholes is obtained by high-input-power RF-MS (Fig. 1c). From crosssectional transmission electron microscopy (TEM; Fig. 1d), selected-area electron diffraction (SAED; Fig. 1e), and highresolution TEM (HRTEM; Fig. 1f) analysis, the Ta_3N_5 film prepared from high-input-power RF-MS is polycrystalline and comprises clustered Ta_3N_5 domains with nanometersized crystalline grains oriented in multiple directions. As shown in Fig. S4 of the ESI,† the two-dimensional fast Fourier transforms (FFT) in several specified areas indicate that the small-sized single-crystalline Ta_3N_5 with several orientations was distributed over a wide area, which is evident from the bright spots (with varying intensities) originating from different crystalline planes (orientations) of Ta_3N_5 clusters. The single-crystal domains of Ta_3N_5 with different orientations were well separated. These results indicate that multiple crystal grains with different lattice orientations are assembled to form polycrystalline Ta_3N_5 thin films. **Example 19**
 Example 19

Using drop-casting and spin-coating methods (Fig. S5(b) and (c), ESI†), the NiFeO_x electrocatalyst was loaded onto the surface of the Ta₃N₅/GaN/Al₂O₃ samples to promote the OER and the stability of the photoanode. Coverage of the Ta_3N_5 surface by the electrocatalyst could be a crucial factor in determining the durability of the OER. To demonstrate this hypothesis, the NiFeO_x is deposited on the Ta₃N₅ surface by either of the above procedures, i.e., drop-casting or spin-coating. Fig. 2(a) and (b)

Fig. 1 Crystalline and structural properties of Ta₃N₅/GaN/Al₂O₃ specimen. (a) XRD patterns of Ta₃N₅/GaN/Al₂O₃ (fabricated by high and low input RF power sputtering), GaN/Al₂O₃ substrate, and Ta₃N₅ reference (DB01-089-5200). Cross-sectional ADF-STEM images of Ta₃N₅ thin film (with thickness of \sim 800 nm) developed using (b) low and (c) high-input-power RF-MS on GaN layer. (d) Cross-sectional TEM image of Ta₃N₅ prepared by high-inputpower RF-MS. (e) SAED of the circle shown in the TEM image of panel (d). (f) HRTEM image of Ta₃N₅/GaN/Al₂O₃. Various parallel lines represent different crystal planes of Ta₃N₅.

show the top-view of SEM images of Ta_3N_5 thin films modified with N iFeO_x through drop-casting and spin-coating, respectively. Using the drop-casting method, the SEM image of the NiFeO $_x$ / Ta_3N_5 specimen indicated separate dark and bright regions corresponding to NiFeO_x deposits and bare Ta₃N₅, respectively. Such random deposition of NiFeO_x species on the Ta₃N₅ surface and the emergence of bare Ta_3N_5 is attributed to the nonuniform nucleation-growth process during solvent evaporation. The direct contact of bare Ta_3N_5 surfaces with an aqueous electrolyte solution facilitates the photooxidation process upon solar illumination, which leads to insulating TaO_x formation and consequently reduces the OER activity.47,59 In addition, the localized deposition of $NiFeO_x$ electrocatalyst with reduced surface area drives a highly constricted current density for OER activity. These highly constricted current density regions can dissolve the electrocatalyst species with higher rate, thereby degrading the OER activity. In contrast, with the spin-coating method, the NiFeO_x electrocatalyst uniformly and homogeneously covered the Ta₃N₅ surface without any exposed Ta₃N₅ region. Compared to the drop-casting method, the high surface coverage of the electrocatalyst prepared by the spin-coating method is evident from the comparison of the SEM images before (see Fig. S6, ESI†) and after (Fig. 2(a) and (b)) the NiFeO_x deposition. The SEM images show that the rough surface of $Ta₃N₅$ is entirely smoothened by electrocatalyst deposition by the spin-coating method, whereas pockets of the smooth (dark) region developed on the Ta_3N_5 surface after the drop-casting method. In addition, the scanning electron microscopy-energy dispersive X-ray spectroscopy (SEM-EDS) mapping in Fig. S7 in the ESI† shows strong and uniform signals of Ni and Fe over the Ta_3N_5 surface, which indicates and confirms the formation of a uniform NiFeO_x electrocatalyst layer on the Ta₃N₅ surface via spin-coating. The durability of the OER can be improved by Energy & Environmental Science

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employing the spin-coating method owing to the less exposed Ta_3N_5 surface and localized current density compared to the drop-casting method for NiFeO_x/Ta₃N₅ photoanodes. Moreover, the cross-sectional ADF-STEM (Fig. 2c) and EDS map (Fig. 2d) reveal that the thickness of $NiFeO_x$ prepared by the spin-coating method is close to 20 nm on the Ta_3N_5 surface prepared by the spin-coating method. From the HRTEM (Fig. 2e) and SAED (Fig. 2f) analyses, the amorphous structure of the NiFeO_x electrocatalyst was detected from the hollow ring in the SAED pattern, which is a typical feature of amorphous materials.⁶³

After NiFeO_x modification, the transparency of the Ta₃N₅/ $GaN/Al₂O₃$ photoanode must be maintained for application in PEC-based tandem cells for unbiased solar water splitting. The UV-Vis-NIR transmittance (Fig. 2g) and reflectance (Fig. 2h) spectra demonstrate that the NiFeO_x/Ta₃N₅/GaN/Al₂O₃ retains an average transmittance of \sim 70% in air and is almost similar to the GaN/Al₂O₃ substrate at wavelengths beyond 600 nm (light absorption edge of Ta₃N₅).⁵⁷ The fringe patterns in the transmittance and reflectance spectra of NiFeO_x/Ta₃N₅/GaN/Al₂O₃ beyond a wavelength of 600 nm originated from light interference in the Ta_3N_5 and GaN layers. These results suggest that the impact of the NiFeO_x coating on the optical properties of the Ta₃N₅/GaN/Al₂O₃ specimen is negligible; therefore, it can be utilized as a front photoanode in a tandem cell configuration for bias-free OWS.

2.2. Photoelectrochemical properties of Ta_3N_5 photoanodes

Before the PEC evaluation of the NiFeO_x/Ta₃N₅/GaN/Al₂O₃ photoanodes, the electrochemical properties of the NiFeO_x electrocatalyst towards OER activity were evaluated and discussed. The electrochemically driven intrinsic OER properties of NiFeO_x could substantially influence the PEC properties of the NiFeO_x/Ta₃N₅/GaN/Al₂O₃ photoanodes. For electrochemical

Fig. 2 Modification of Ta₃N₅ surface with NiFeO_x electrocatalyst. Top-view SEM images of NiFeO_x/Ta₃N₅/GaN/Al₂O₃ samples prepared by (a) dropcasting and (b) spin-coating methods. (c) Cross-sectional ADF-STEM image, (d) EDS map, (e) HRTEM image, (f) SAED pattern (corresponding to orange circle in panel (e)), UV-Vis-NIR (g) transmission, and (h) reflectance spectrum with wavelength of NiFeO_x/Ta₃N₅/GaN/Al₂O₃ photoanode developed by spin-coating method (red) and GaN/Al₂O₃ substrate. In panel (d), Fe, Ni, O, N, and Ta elements (with respect to panel (c)) are mapped by green, yellow, orange, light blue, and dark blue colors, respectively.

measurements, NiFeO_x/Au/Ti electrodes (shown in Fig. S8, ESI†) were prepared using the drop-casting/spin-coating method and measured under dark conditions. The details of the preparation protocol for the NiFeO_x/Au/Ti electrodes are described in Materials and Methods. Fig. 3a and Fig. S9 in the ESI[†] show the cyclic voltammogram (CV) of the NiFeO_x/Au/Ti electrodes. In the electrodes' CV characteristics, the OER's onset potential corresponds to the electrode potential required to generate an anodic current of 0.1 mA cm $^{-2}$. Without the *iR*drop correction, the results suggest that the NiFeO_x/Au/Ti electrode (from the spin-coating method) exhibits an anodic onset potential of 1.48 V_{RHE} . An additional electrode potential of 1.53 V_{RHE} or overpotential (from the standard water redox potential, 1.23 V_{RHE} , for OER activity) of 0.3 V is required to drive OER activity at a current density of 10 mA $\rm cm^{-2}.$ This overpotential is almost comparable to that of previously reported binary and trinary metal oxide-based electrocatalysts such as $NiFeO_x$, $NiCoO_x$, and $NiFeCoO_x$.⁶⁴ Compared to the spin-coating method, an almost similar onset potential (1.48 V_{RHE}) and overpotential (0.3 V) were determined for the electrode prepared by the drop-casting method (see Fig. S9a, ESI[†]) with a surface loading value of 0.1 µmol cm⁻².⁵⁹ Moreover, the iR -drop-corrected CV curves for the NiFeO_x/Au/Ti **Paper**
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electrodes display comparable onset potentials and overpotentials, regardless of the methods employed for electrocatalyst loading (in Fig. S9b, ESI†).

The PEC properties of the semitransparent NiFeO_x/Ta₃N₅/ GaN/Al₂O₃ photoanode include onset potential, photocurrent density at the standard water redox potential $(1.23 V_{BHE})$ for OER activity, and water-splitting efficiency, were assessed under simulated AM1.5G solar illumination. The measurements were performed using a three-electrode configuration, as shown in Fig. S10 of ESI.[†] The PEC properties of Ta₃N₅ film with thicknesses ranging from 100 nm to 1000 nm were evaluated. The optimized Ta_3N_5 thickness of 800 nm produces a high photocurrent of \sim 7.4 mA cm $^{-2}$ at 1.23 V_{RHE} (see Fig. S11, ESI†). Fig. 3b shows the photocurrent density (J) –potential (E) $(J-E)$ curve of optimized NiFeO_x/Ta₃N₅/GaN/Al₂O₃ semitransparent photoanode, prepared by spin-coating method, measured in a 1 M KOH aqueous solution with pH 13.8. A photocurrent of over 0.1 mA cm^{-2} is observed at a photoanode potential of more than 0.60 V_{RHE}. We called this potential the onset potential E_{on} of the photoanode for the OER activity. From Fig. 3(a) and (b), the difference in the onset potential (ΔE_{on}) of the NiFeO_x/Au/Ti electrode (1.48 V_{RHE}) and NiFeO_x/Ta₃N₅/GaN/ Al_2O_3 photoanode (0.60 V_{RHE}) is 0.88 V. ΔE_{on} indicates that the

Fig. 3 Photoelectrochemical features of Ta₃N₅ photoanode. (a) CV of NiFeO_x/Au/Ti electrode, prepared by spin-coating method, at potential scan rate v (10 mV s⁻¹) under dark condition. (b) J–E curve of NiFeO_x/Ta₃N₅/GaN/Al₂O₃ semitransparent photoanode, prepared by spin-coating method, under chopped simulated AM1.5G solar illumination. (c) HC-STH energy conversion efficiency and FOM as a function of photoanode potential. (d) IPCE spectra of photoanodes (red: prepared by high-input-power RF-MS; blue: prepared by low-input-power RF-MS). (e) Chronoamperograms for NiFeOx/Au/Ti electrode at the electrode potential of 1.5 V_{RHE} under dark condition (red: NiFeO_x prepared by spin-coating; blue: NiFeO_x prepared by drop-casting). (f) Evolution of current density of photoanodes at potential of 1.23 V_{RHE} with time t (red: from spin-coating method, blue: drop-casting method) under continuous AM1.5G solar illumination. The measurements were performed in 1 M KOH aqueous solution with pH 13.8. The current density in (b and f) was obtained by normalizing the measured current (in three-electrode configuration) with the photoactive area (0.84 cm² – spin coating; 0.86 cm² – drop casting) of photoanodes, prepared by high-input-power RF-MS system.

photogenerated charge carriers inside the Ta_3N_5 layers reduce the applied potential required to initiate the OER activity. The onset potential of the fabricated photoanode is close to the previously reported NiFeO_x-modified Ta₃N₅ photoanodes prepared on the Ta,⁴⁷ GaN/Al₂O₃,⁵⁷ and quartz substrates.^{26,59} On the other hand, we observed a cathodic (or negative) shift of the onset potential compared to the communicated single metal oxide-based electrocatalyst (such as CoP_i, CoO_x, NiO_x, and FeO_x) loaded Ta₃N₅ photoanodes.^{47,65–67} In the literature, the onset potential of the Ta_3N_5 -based photoanodes ranges from 0.5 V_{RHE} to 0.8 V_{RHE} , irrespective of preparation procedure, substrates, cation-doping, and electrocatalysts.^{47,50,53,59} Although the void-free Ta_3N_5 thin film is successfully developed herein, the Fermi-energy level pinning effect caused by surface (oxygen impurity and/or nitrogen-vacancy) defect states may limit the realized onset potential of NiFeO_x/Ta₃N₅/GaN/Al₂O₃ photoanodes. 46 Besides, the photocurrent density *J* rises with increasing applied potential E and reaches \sim 7.4 mA cm⁻² at 1.23 V_{RHE}. As shown in Fig. S12 of ESI,[†] the NiFeO_x/Ta₃N₅/GaN/ Al2O3 photoanodes exhibit a reproducible photocurrent density of more than 7 mA cm^{-2} at 1.23 V_{RHE} . Although the photocurrent varies slightly from sample to sample, an average photocurrent density of 7.37 \pm 0.06 mA cm $^{-2}$ at 1.23 $\rm V_{RHE}$ is realized from five different Ta_3N_5 -based photoanode samples. The realized photocurrent at 1.23 V_{RHE} is 60% of the theoretical current limit of 12.4 mA $\rm cm^{-2}$ of Ta $_{3}N_{5}$ (for bandgap energy of 2.1 eV) at an external quantum efficiency of 100% .²⁵ The photoanode prepared by high-input-power RF-MS exhibits an enhanced photocurrent density of 1.1 mA $\rm cm^{-2}$ at 1.23 $\rm V_{RHE}$ compared to the photoanode developed with a conventional low-input-power RF-MS system (70 W) .⁵⁷ Compared to the spincoated NiFeO_x electrocatalyst, the drop-casting modification of the Ta_3N_5 surface leads to similar current potential features (e.g., 7.3 mA cm $^{-2}$ at 1.23 V_{RHE}; see Fig. S13, ESI†). Energy & Environmental Science

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Fig. S14 of the ESI† presents the PEC characterization of NiFeO_x/Ta₃N₅/GaN/Al₂O₃ photoanodes prepared by high (optimized) and low- (non-optimized) input-power RF-MS techniques. The optimized Ta_3N_5 photoanode exhibits larger photocurrents than non-optimized Ta_3N_5 photoanode in absence and presence of hole scavenger (H_2O_2) (Fig. S14(a) and (b), ESI†). The J –E curves for Ta₃N₅ photoanodes, acquired in electrolyte containing H_2O_2 , facilitate the estimation the charge injection and charge separation efficiencies of photoanodes, in accordance with the previous reports.⁷ The charge injection efficiency (Fig. S14c, ESI†) of optimized photoanode is higher (\sim 80% at 0.9 V_{RHE}) than that of non-optimized sample (\sim 60% at 1.0 V_{RHE}). Similarly, the charge separation efficiency (Fig. S14d, ESI†) of optimized photoanode is higher than that of non-optimized photoanode. Besides this, in Fig. S14e of ESI,† the Nyquist plots under AM1.5G illumination at potential of 1.23 V_{RHE} indicate relatively low charge transfer resistance (for hole transfer from Ta_3N_5 surface to electrolyte) of optimized photoanode as compared to non-optimized sample. These results suggest enhanced bulk and surface properties of optimized Ta_3N_5 to suppress recombination of charge carriers for efficient extraction of holes for OER activity. From Mott-Schottky

analysis in Fig. S14f of ESI,† the flat band potential of optimized and non-optimized photoanodes are 0.19 V_{RHE} and 0.31 V_{RHE} , respectively.

Fig. 3c presents the half-cell solar-to-hydrogen (HC-STH) energy conversion efficiency and ratio-metric power-saved figure of merit (FOM) at various applied potentials of the NiFeO_x/ $Ta_3N_5/GaN/Al_2O_3$ photoanode. A schematic illustration and governing equations for evaluating the above performance metrics are provided in Fig. S15 in the ESI† and Materials and methods section (in ESI†), respectively. The maximum HC-STH efficiency and FOM are 1.35% at 0.9 V_{RHE} and 2.7% at 1.0 V_{RHE} , respectively. A significant improvement in the maximum HC-STH energy conversion efficiency is observed in comparison to the previously reported NiFeO_x/Ta₃N₅/GaN/Al₂O₃ photoanode (1.15% at 0.94 $\rm{V_{RHE}})^{57}$ and $\rm{CoO_{\rm\it x}\textrm{-}loaded}$ $\rm{Ta_{3}N_{5}/Ta}$ photoanode (1.0% at 1.0 V_{RHE}).⁴⁷

Fig. 3d unveils photoanodes' incident-photon-to-current efficiency (IPCE) at 1.2 V_{RHE} for different wavelengths of incident monochromatic light. The NiFeO_x/Ta₃N₅/GaN/Al₂O₃ photoanodes generated an anodic current in response to light absorption at wavelengths less than 600 nm. The onset of the photocurrent response with the decrease in the wavelength is often called the light absorption edge (\sim 600 nm), which agrees with the reported Ta₃N₅ literature value.⁴² Tauc plot (derived from IPCE spectra) determines the bandgap energy of 2.06 eV (Fig. S16 in the ESI†). The IPCEs of the fabricated photoanode through the high-input-RF power are higher than the sample produced by low-input-power RF-MS.⁵⁷ The enhanced IPCE spectra is consistent with the improved photocurrent density (by 1.1 mA cm^{-2}) of the photoanodes,⁵⁷ developed by highinput-power RF-MS (in Fig. 3b). In addition, the IPCEs increased with a decrease in wavelength. Light absorption at short wavelengths (e.g., 420 nm) produces charge carriers that are relatively closer to the surface than long wavelengths (500 nm). The photogenerated holes either diffused to the Ta_3N_5 surface for OER activity or were annihilated via recombination in the bulk of Ta₃N₅. The qualitative description of charge carrier transport suggests that charge carriers closer to the surface are less likely to recombine than more distant charges, resulting in the observed IPCE spectra.

The stability of the Ta_3N_5 -based photoanode is critical and could depend on the durability of the NiFeO_x electrocatalyst during OER activity. To investigate the durability of NiFeO_x, NiFeO_x was loaded over the Au/Ti electrodes by drop-casting or spin-coating. Fig. 3e shows the chronoamperograms of the light-insensitive NiFeO_x/Au/Ti electrodes. These measurements were performed in a 1 M KOH aqueous solution with a pH of 13.9. With NiFeO_x/Au/Ti electrodes, the electrode potential was modulated from 0.9 to 1.5 V_{RHE} at an initial time $t = 0$ h to produce OER activity at the anodic current density of 10.9 mA cm^{-2} and 8.3 mA cm^{-2} from spin-coating and dropcasting methods, respectively. The current densities generated by both electrodes gradually decreased to 5 mA cm^{-2} after 5 h of electrochemical operation. The degradation in the current could originate from the loss of OER-active Fe species, which dissolve into the electrolyte solution as the most likely $FeO₄²⁻$

species.^{68–70} Compared to the NiFeO_x-loaded surface with the drop-casting method, the rate of current density degradation is higher for the NiFeO_x-loaded surface with the spin-coating method owing to the larger dissolution of Fe species driven by high current density levels. The fraction of the $NiFeO_x$ loaded surface retaining the OER-active Fe species $f(t)$ decreases with time t as follows:

$$
\frac{\mathrm{d}}{\mathrm{d}t}f(t) = -k_{\text{diss}}J(t)f,\tag{1}
$$

where $J(t)$ is the current density and k_{diss} is the dissolution rate constant. As shown in Fig. S17 of ESI,† the dissolution rate constant k_{diss} of NiFeO_x-loaded with the spin-coating method was 1.3 times larger than the k_{diss} of the NiFeO_x-loaded surface with the drop-casting method. After the Fe species dissolution, the NiFe O_x -loaded surface's electrical resistivity increased. This degraded electrical surface resistivity is 1.6 times larger for the $NiFeO_x$ -loaded surface with the spin-coating method compared to the NiFeO_x-loaded surface with the drop-casting method. Although the initial current density is higher, the dissolution rate constant and electrical resistivity after the dissolution of Fe species are also higher for the $NiFeO_x$ -loaded surface with the spin-coating method than for the NiFeO_x-loaded surface with the drop-casting method.

Using similar deposition techniques and conditions, the electrocatalyst was loaded to develop NiFeO_x/Ta₃N₅/GaN/Al₂O₃ photoanodes, and their impact on the durability of lightinduced OER activity was investigated. As mentioned in Fig. 2, the uniform and non-uniform distributions of NiFeOx on the Ta₃N₅ surface were detected by spin-coating and dropcasting method, respectively. With a high-quality (void-free) Ta_3N_5 thin film, Fig. 3f exhibits the impact of electrocatalyst deposition methods on the photocurrent density's time (t) evolution at 1.23 V_{RHE} on NiFeO_x/Ta₃N₅/GaN/Al₂O₃ photoanodes under simulated AM1.5G solar illumination. The initial J (at $t = 0$ min) for the Ta₃N₅/GaN/Al₂O₃ sample with low (or non-uniform) coverage by N_1FeO_x (drop-casting method) was lower than that of the Ta₃N₅/GaN/Al₂O₃ specimen with high (or uniform) NiFe O_x coverage (spin-coating method). The photocurrents herein are consistent with the observations from the J–E curves in Fig. 3b and Fig. S13 in ESI.† During the first 5 min of operation, a rapid decrease in photocurrent with time is characterized by high surface electrocatalyst coverage compared to that of low-surface-coverage-based samples. However, the high surface coverage photoanode achieved a stabilized photocurrent of 3.8 mA cm^{-2} after 80 min. In contrast, the photocurrent of the photoanode with low surface coverage decayed rapidly within 30 min of the photoelectrode operation. This improved stability of Ta_3N_5 -based photoanode displays the crucial impact of (uniform vs. non-uniform) surface protection by NiFe O_x .

These results demonstrate the correlation between the photoanodes' durability, electrocatalyst's intrinsic stability, and surface modification of Ta_3N_5 with an electrocatalyst. For instance, the deposition method did not significantly affect the overall intrinsic stability (Fig. 3e) of the electrocatalyst for up to

5 h. However, the electrocatalyst's high coverage (uniform) of the Ta_3N_5 surface showed enhanced photocurrent stability of up to 80 min, whereas the low surface coverage led to a rapid photocurrent decay within 30 min (Fig. 3f). This contrasting evolution of J with t indicates that an additional process could be involved in the J degradation of the photoanodes. In order to understand the real degradation mechanism of Ta_3N_5 photoanode towards OER activity, we performed the PEC measurement of bare-Ta₃N₅/GaN/Al₂O₃ photoanode under AM1.5G solar illumination. Before stability test, the bare Ta_3N_5 photoanode exhibits anodic photocurrent at applied potentials beyond onset potential of 1.1 V_{RHE} , which reaches to \sim 0.16 mA cm⁻² at applied potential of 1.23 V_{RHE} (Fig. S18a in red line, ESI†). However, the photocurrent of bare Ta_3N_5 photoanode ceases to exist within few minutes of continuous water splitting operation (Fig. S18(a) and (b), ESI†). X-ray photoelectron spectroscopy (XPS) analysis revealed the formation of TaO_x and nitrogen vacancies after the stability test of the photoanodes (Fig. S19, ESI†). The Ta 4f peak shifted to a higher binding energy after the stability tests. In addition, the peaks of Ta 4f, N 1s, and O 1s in the XPS spectra can be observed at lower binding energy after continuous Ar etching (Fig. S20, ESI†), indicative of the removal of the TaO_x layer on the Ta₃N₅ surface via surface etching. The shift of the Ta 4f peaks towards lower binding energies is most likely due to the Fermi level pinning of Ta_3N_5 .⁴⁶ These XPS observations indicate that the insulating TaO_x layer is created at the Ta₃N₅/electrolyte interface with continuous OER activity. Thus, the durability of the NiFeO $_{\rm v}$ / Ta₃N₅/GaN/Al₂O₃ photoanodes was influenced by NiFeO_x dissolution and insulating TaO_x formation. Increasing the loading amount or thickness of NiFe O_x electrocatalyst could improve the durability of Ta_3N_5 photoanode for OER activity. However, the NiFeO_x loading amount suppresses the light absorption inside Ta_3N_5 layer as well as decreases the light transmittance (essential to power the bottom CuInSe₂ solar cells) at wavelengths longer than 600 nm (evident from Fig. S21, ESI†). Owing to such limitation on optical properties, the NiFeO_x loading amount could not be increased beyond a certain threshold value for the improvement of durability along with the current density at 1.23 V_{RHE} . Nevertheless, the stability of the Ta_3N_5 -based photoanode is improved with uniform surface modification by electrocatalyst coating compared to a previous report (where the OER activity ceases to exist beyond 15 min).⁵⁷ **Example 12**
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2.3. Application of Ta_3N_5 photoanodes for bias-free solar water splitting

Fig. 4a shows a schematic of the PEC–PV tandem cell. The tandem cell is composed of serially connected NiFeO_x/Ta₃N₅/ GaN/Al₂O₃ photoanode (top), dual-CuInSe₂ (CIS)-based PV elements (behind the photoanode), and Pt/Ni electrodes. An ITOcarbon conductor housing connects the individual elements of the tandem cell. Under simulated AM1.5G solar illumination, photogenerated holes from the Ta₃N₅ film were utilized for OER activity, whereas the GaN layer extracted electrons. These extracted electrons recombine with the holes produced inside the CIS elements; however, the light-generated electrons of the

Fig. 4 Bias-free overall solar water splitting from Ta₃N₅-CuInSe₂-based tandem device. (a) Schematic diagram of a tandem cell, composed of NiFeO_x/ Ta₃N₅/GaN/Al₂O₃ photoanode, dual-CuInSe₂ PV cells, and Pt/Ni electrode. (b) J–E curves of Ta₃N₅ photoanode (in front) and dual-CuInSe₂ PV cells (behind photoanode) with respective photoactive area of 0.84 cm² and 0.80 cm². (c) Time evolution of STH energy conversion efficiency (left axis) and current density J (right axis) of the tandem cell. Here, J is determined by the ratio of current to photoactive area of Ta₃N₅ photoanodes. The Ta₃N₅ surface is loaded with high (red) and low (blue) coverage of NiFeO_x with photoactive area of 0.84 cm² and 0.86 cm², respectively. (d) Evaluated evolution of hydrogen and oxygen gases, based on charge flow in panel (c) and faradaic efficiency of 98%.

CIS elements reach the Pt/Ni electrode for HER activity. Details of CIS-based PV elements including J–V characteristics are given in the Materials and methods section and Fig. S22 of the ESI.† Hence, in Fig. 4b, the tandem cell operates with the matched photocurrent (from photoanode and CIS-based PV elements) close to 7.3 mA $\rm cm^{-2}$ at the 1.2 $\rm V_{RHE}$. Considering a faradaic efficiency of $98\%,^{57}$ the Ta₃N₅-CIS tandem device drives bias-free solar water splitting with an STH energy conversion efficiency of 9%, which is higher than that of metal oxide/nitride-based tandem cells (see Table S1 and Fig. S2 of ESI†). Besides photocatalytic (metal oxide/nitride) materialsbased PEC–PV tandem systems, the PV grade materials-based wireless multijunction and PEC–PV tandem devices reached state-of-the-art STH efficiency up to \sim 20% and durability up to 100 h (see Tables S2 and S3 of ESI†). However, the practical application of PV materials-based tandem systems could be limited or hindered due to high fabrication cost of multijunction and presence of unhealthy lead content in PEC–PV systems.

Fig. 4c shows the time evolution of the STH energy conversion efficiency of the tandem device. Although a spike-like (from capacitive response) photocurrent was initially observed, the non-faradaic process was expected to last a few seconds. For the photoanode surface modified by spin-coating method, the STH energy conversion efficiency of the tandem cell is about 9% after 0.25 min, which is maintained at more than 7% for 2 min. However, the tandem device based on the photoanode modified by the drop-casting method exhibited a relatively low STH energy conversion efficiency of 8% and durability for 1 min for efficiency beyond 7%. In Fig. 4d, the tandem cell with a high surface coverage photoanode displays relatively long-term durability of over 2 h to maintain the STH energy conversion efficiency above 4%. On the other hand, the STH energy conversion efficiency decayed rapidly to 4% within 20 min from a tandem device with a low-surface-coverage photoanode. These results demonstrate that the high coverage of the Ta_3N_5 surface by the NiFeO_x electrocatalyst could extend the durability of overall solar water splitting. The effect of the electrocatalyst surface coverage on the durability of the tandem device was consistent with the stability test of NiFeO_x/Au/Ti electrodes and Ta_3N_5 -based photoanodes. Therefore, the tandem PEC cell durability test results demonstrated that the electrochemical characteristics of the electrocatalyst loaded on the photoelectrode surface affect the PEC properties of the photoelectrodes. To achieve efficient water splitting in the PEC water-splitting system, we show that the semiconductor properties of the photoelectrode materials and the electrocatalytic properties of the electrocatalyst, which functions as a surface modification layer, can be simultaneously evaluated, and that the PEC watersplitting rate can be significantly improved by designing a sophisticated solid/liquid interface.

2.4. Charge carrier dynamics of Ta_3N_5 thin film

The performance metrics of the photoanode, and hence the tandem cell, are generally limited by the recombination and/or trapping of photogenerated charge carriers inside the Ta_3N_5 thin film in addition to charge transfer to the electrolyte via $NiFeO_x$. Accessing these properties is crucial for determining the governing material parameters and developing design guidelines for the performance enhancement of photoanode/ tandem cells. For this, TAS measurements of the $Ta_3N_5/GaN/$ Al_2O_3 sample (fabricated by high-input-power RF-MS) were performed to probe the dynamics of the absorption signal $S(t)$ decay in the picosecond to microsecond time t range. The details of the TAS measurements are incorporated in the ESI.† The sample was excited by a pump photon energy of 3.1 eV to produce charge carriers inside a light penetration depth of 34 nm (\sim 1/ α _a; α _a = 2.91 \times 10⁵ cm⁻¹ is the absorption coefficient) at various pump fluence intensities P_{FL} (0.075 to 4.5 μ J per pulse). According to the Lambert-Beer law, the initial density of the Paper

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photogenerated charge carriers $\Delta n_0 = 1.88 \times 10^{20} \text{ cm}^{-3}$ at $P_{\text{FL}} =$ 3 µJ. These hot charge carriers relax rapidly in the femtoseconds to sub-picoseconds time scale by intraband relaxation processes and accumulate at the edge of valence and conduction bands. $71-73$ After intraband relaxation, the decay response of charge carriers is captured with a probe photon energy of 0.24 eV, and the resultant time evolution of $S(t)$ was measured for different P_{FL} .

Fig. 5 unravels the dominant relaxation of the charge carriers behind the measured TAS characteristics of the Ta₃N₅ thin film. In Fig. 5a, the integrated photoluminescence (PL) spectrum and Tauc plot of the absorption coefficient (α_a) spectrum show a bandgap energy of \sim 2.1 eV. In addition, from Fig. 5b, the results indicate that the decay rate of $S(t)$ increases with an increase in P_{FL} , a typical bimolecular recombination feature of charge carriers. Moreover, the maximum absorption signal S_m ($t \sim 0.4$ ps) increases almost linearly with an increase in P_{FL} , photon density I_p , or Δn_0 (Fig. S23 of ESI†), *i.e.*, S_m = $\beta \Delta n_0$, where β is the proportionality constant. Additionally, $S(t)$ exhibits the power-law decay $S(t) = At^{-\alpha}$ in the nanosecond to microsecond time range for various P_{FL} , where A is the amplitude and α is the exponent. For n-type doped $Y_2Ti_2O_5S_2$ photocatalyst, the power-law absorption decay features in the submicrosecond time range were attributed to the detrapping of

Fig. 5 Charge carrier dynamics of Ta₃N₅ thin film. (a) Normalized integrated PL spectrum (left axis) between -0.1 ns and 0.7 ns obtained from picosecond time-resolved PL measurements for laser excitation of 3.1 eV, and Tauc plot (right axis) of absorption coefficient (α_a) spectrum. (b) Absorption signal S(t) decay characteristics with time t at pump and probe photon energy of 3.1 eV and 0.24 eV, respectively. The S(t) follows power-law decay At⁻³ (dotted lines) after around ten ns, where A and a is defined as the amplitude and exponent, respectively. (c) Proposed numerical model with band-toband charge carrier recombination, trapping and detrapping of holes from exponential tail trap states $N_{\mathcal{G}}(E)$. The detail of model description is provided in ESI.† (d) At^{-«} (at t = 1 ps) and exponent « (inset) at various P_{FL} . The dotted line represents $\beta p_t^{\rm A}$ (at t = 1 ps), where β and $p_t^{\rm A}$ corresponds to the proportionality constant and analytical trapped hole density ρ_t^Λ expressed by eqn (2), respectively. The dotted line in inset is a guide to eyes. (e) Time evolution of S(t) measured at $P_{FL} = 3 \mu J$ (red line) and simulated density of trapped holes $p_t(t)$ (pink dotted line), mobile electrons $\Delta n(t)$ (blue line) and holes $\Delta p(t)$ (black dotted line). (f) Mapping of trapped holes p_t (E, t) at energy E in cm $^{-3}$ eV $^{-1}$, $\Delta n(t)$ (solid circles) and $\Delta p(t)$ (open circles) in cm $^{-3}$ at various time t for $P_{FL} = 3 \mu J$.

holes from shallow exponential tail trap states of the valence band.⁷⁴ From Hall effect measurements, the n-type doping density (n_d) of the Ta₃N₅ thin film is significantly high $(1.01 \times 10^{20} \text{ cm}^{-3})$. Following the Fermi-Dirac statistics, such a high n_d leads to a Fermi-level energy close to the minimum energy of the conduction band and consequently fills the shallow trap states (if present) in the vicinity of the conduction band minimum. However, the shallow defect states near the valence band maximum can contribute to trapping/detrapping of holes. Considering these arguments, Fig. 5c presents the proposed numerical model to encapsulate dominant relaxation processes, such as bimolecular recombination of mobile charge carriers and trapping and detrapping of holes via exponential tail trap states of the valence band. The theoretical model formulations are included in the ESI.† As derived previously, 74 the dynamics of the trapped hole density govern the power-law decay $(S(t) = At^{-\alpha})$ and is given by

constant, temperature, and characteristic energy of the exponential tail trap states, respectively. Fig. 5d shows the calibration of the analytical model ($\beta p_t^A(t)$ at $t = 1$ ps) to the variation of $At^{-\alpha}$ (at $t = 1$ ps) with P_{FL} evaluated from Fig. 5b and determines the initial guess of the relevant material parameters. The numerical simulations were well-calibrated to the measured absorption signal decay characteristics with parameter fine-tuning and validated for the entire range of P_{FL} , as shown in Fig. 5e and Fig. S24 of ESI.† Fig. 5(e) and (f) display the time evolution of the charge carriers at $P_{FL} = 3 \mu J$. In addition to recombination with electrons, mobile holes undergo a trapping process with exponential tail trap states, accumulating holes inside the trap states and mobile charge carrier decay. Compared with electrons, mobile holes decay faster with time. After $t \sim 10$ ps, the electron decay was dominated by recombination with the detrapped holes. This hole detrapping process induces slower decay kinetics of mobile electrons.

$$
p_t^A(t) = N_t \pi \alpha / ([1 + n_d/\Delta n_0] \Gamma(1 - \alpha) \sin(\pi \alpha) (k_t N_v t)^{\alpha}).
$$
 (2)

here, N_t , k_t , $\Gamma(x)$, and N_v are the trap density, trapping rate constant for mobile holes, gamma function, and effective density of states for the valence band, respectively. Furthermore, the exponent $\alpha = k_B T/E_0$, where k_B , T, and E_0 are the Boltzmann

The theoretical analysis of the TAS measurements determined various essential material parameters of the Ta_3N_5 thin film, as summarized in Table S4 in the ESI.† For instance, the evaluated $n_d = 8 \times 10^{19}$ cm⁻³ corroborates well with the Hall effect measurements $(1.01 \times 10^{20} \text{ cm}^{-3})$, whereas the quantified recombination rate constant k_r (= 10^{-9} cm³ s⁻¹) is close to the typical values of direct-bandgap semiconductors such as

Fig. 6 Optoelectrical simulation of the semitransparent Ta₃N₅ thin film-based photoanode. (a) Simulated light transmission (TR), reflection (RF) and absorption (Abs). (b) Fraction of AM1.5G solar spectrum (shaded gray area), absorbed (Abs × AM1.5G, shaded green area), and harvested (IPCE × AM1.5G, shaded blue area) along with the respective integrated current denisty. (c) The generation rate of charge carriers G with position x across Ta₃N₅ thin film (green line), evaluated using eqn (S16) (of ESI†). Here, q (\sim 1.602 \times 10 $^{-19}$ C) is the elementary charge. (d) Simulated trend of current density at 1.23 V_{RHE} against hole diffusion length $L_{\sf dn}$. The shaded area is the regime around the measured current density of 7 mA cm⁻². (e) Measured (in red) and simulated (blue line) J–E characteristics. (f) Energy band diagram and charge carrier generation (G)/recombination rate (R) with position x across Ta₃N₅ thin film corresponding to current density 7 mA cm⁻² at 1.23 V_{RHE}. Model calibration to the experimental data enables the estimation of performance-limiting parameters of the fabricated Ta₃N₅ photoanode. E_c, E_v, F_n, and F_p correspond to the energies of conduction band, valence band, quasi-Fermi-level for electrons and holes, respectively.

GaAs and lead halide perovskites. With carrier generation under AM1.5G solar illumination (*i.e.*, $\Delta n_0 < n_d$), the evaluated carrier lifetime $(k_r n_d)^{-1}$ for recombination was only 12.5 ps. Moreover, the exponential tail trap states exhibit $E_0 = 104$ meV, $N_{\rm t}$ = 9 \times 10¹⁹ cm⁻³ and $k_{\rm t}$ = 2 \times 10⁻⁹ cm³ s⁻¹. Such shallow trap states can additionally influence effective carrier lifetime and mobility.

2.5. Optoelectrical simulations of the Ta_3N_5 photoanode

Optoelectrical numerical modeling was employed to decipher the parameters governing the $J-E$ characteristics of the fabricated NiFeO_x/Ta₃N₅/GaN/Al₂O₃ semitransparent photoanode. Previously, optoelectrical modeling was utilized to study a wide range of solar energy harvesting materials and devices.⁷⁵⁻⁷⁸ Fig. 6 shows the model calibration through optical and electrical simulations with the experimental data to extract performancelimiting parameters for the fabricated photoanode. Optical simulations using the complex refractive index shown in Fig. S25 in the ESI† revealed that the simulated light absorption below and transmission above the absorption edge (600 nm), shown in Fig. 6a, are in the range of 70–80%. Shorter wavelength sunlight is absorbed close to the solid/liquid interface; however, longerwavelength sunlight penetrates deeper into the Ta_3N_5 thin film to generate charge carriers. The comparison of light absorption (Fig. 6a) and IPCE (Fig. 3d) suggests that the photogenerated charge carriers close to the electrolyte interface are extracted efficiently. In contrast, a significant fraction of charge carriers penetrating the Ta_3N_5 thin film are lost by recombination, leading to inefficient charge extraction.

Concerning the theoretical maximum current of 12.4 mA cm^{-2} for 2.1 eV, in Fig. 6b, the absorbed and harvested spectrum constitute an integrated current density of 9.27 and 7 mA $\rm cm^{-2}$, respectively, indicating that current densities of nearly 3.13 mA $\rm cm^{-2}$ and 2.27 mA $\rm cm^{-2}$ were lost through reflection and recombination in the fabricated photoanode, respectively. Fig. 6c presents the calculated charge carrier generation rate G across the thickness of Ta_3N_5 using the modified Lambert-Beer law (eqn (S16), ESI†) such that the integrated current density from G and the simulated absorption are equal. Using electrical simulations, Fig. 6d indicates that the current density at 1.23 V_{RHE} decreases with the decrease in the hole diffusion length L_{dh} . In addition to optical loss, the current at 1.23 V_{RHE} is lowered by bimolecular recombination at low L_{dh} . The mapping of the experimental current density range from 6.5 mA cm^{-2} to 8 mA cm^{-2} in Fig. 6d roughly estimates the L_{dh} in the range of 302 nm to 677 nm. The measured and simulated current density at 1.23 V_{RHE} must be compared to obtain an initial estimate of L_{dh} . Fig. 6e suggests that the simulation agrees with the experimental $J-E$ curve of the fabricated photoanode. This model calibration extracted performance-limiting parameters, as shown in Table S5 in the ESI.† We observe that the performance metrics such as the current density at 1.23 V_{RHE} (*J*_a), fill factor (FF), and onset potential (E_{on}) are governed by parameters such as the minority hole diffusion length L_{dh} , hole extraction rate S_h from the Ta₃N₅ surface to the electrolyte, and parasitic series resistance R_s .

Furthermore, in Fig. 6f, we provide the calculated energy band diagram and the generation and recombination rate of charge carriers under the operating condition with a current density of 7 mA cm^{-2} at 1.23 V_{RHE} .

3. Conclusion

A highly efficient and durable NiFeO_x/Ta₃N₅/GaN/Al₂O₃ semitransparent photoanode was established for a tandem cell configuration coupled with photovoltaics. A high-quality Ta_3N_5 thin film was fabricated using high-input-power radiofrequency magnetron sputtering (RF-MS), resulting in dense, void-free deposition of metallic Ta as an excellent precursor. With a Ta_3N_5 -based photoanode prepared by high-inputpower RF-MS, we demonstrated a photocurrent density of \sim 7.4 mA cm⁻² at 1.23 V vs. a reversible hydrogen electrode (V_{RHE}) , which was higher than that of the photoanode created by conventional low-input-power RF-MS. Moreover, an almost stabilized current density of 4 mA cm^{-2} at 1.23 V_{RHE} was observed for more than 1 h of OER. This durability was otherwise impossible to achieve, where the direct contact of bare Ta_3N_5 to the electrolyte was minimized by the spin coating of NiFeO_x, forming a uniform layer that covers the Ta₃N₅ surface, in sharp contrast with the drop-casting coating forming NiFeO_x islands. The optimized photoanode exhibited a maximum half-cell solar-to-hydrogen (HC-STH) energy conversion efficiency and ratio-metric power-saved figure of merit (FOM) of 1.4% at 0.9 V_{RHE} and 2.7% at 1.0 V_{RHE} , respectively. Finally, the developed photoanode was integrated with dual- $CuInSe₂$ photovoltaic cells to construct a photoelectrochemical–photovoltaic tandem device for bias-free overall solar water splitting. This tandem cell achieved a STH efficiency of 9% at the initial stage of the reaction, which is the highest among previously reported metal oxide/nitride-based tandem devices. In addition, a stable STH efficiency of 4% was demonstrated for 2 h of device operation. Furthermore, various measurements and theoretical simulations were performed to decipher the charge carrier dynamics and determine the unknown material parameters (such as recombination/trapping rate constants, doping density, lifetime, *etc.*) of the fabricated Ta_3N_5 -based photoanode. We believe that our work presents significant advancements toward developing narrow-bandgap semiconductors for eco-friendly, sustainable, and practical solar hydrogen production. **Example 19**

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Data availability

The data that support the findings of this work are available from the corresponding authors upon reasonable request.

Author contributions

T. H. and H. N. designed the photoelectrode concept and performed the experiments related to the preparation of $Ta_3N_5/$ GaN/Al₂O₃ photoanodes and Pt/Ni/dual-CuInSe₂ electrode, PEC

measurements, and data analysis. T. H., Y. K., and K. T. performed electrochemical measurements for $NiFeO_x$ electrocatalyst and data analysis. Y. P., Y. K., and Y. S. performed material characterization (SEM-EDS) and surface modification of Ta₃N₅/GaN/Al₂O₃ photoanode. V. N. and K. S. conducted the theoretical analysis and simulations. R. S. and H. M. performed TAS and PL measurements. M. N. and N. S. performed TEM and STEM observations and data analysis. K. D. planned and supervised this project. T. H., V. N., Y. P., K. S., and K. D. wrote the manuscript. All the authors contributed to the manuscript revisions.

Conflicts of interest

The authors declare no competing interest.

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References

- 1 M. G. Walter, E. L. Warren, J. R. McKone, S. W. Boettcher, Q. Mi, E. A. Santori and N. S. Lewis, Chem. Rev., 2010, 110, 6446–6473.
- 2 J. R. McKone, N. S. Lewis and H. B. Gray, Chem. Mater., 2014, 26, 407–414.
- 3 J. Jia, L. C. Seitz, J. D. Benck, Y. Huo, Y. Chen, J. W. D. Ng, T. Bilir, J. S. Harris and T. F. Jaramillo, Nat. Commun., 2016, 7, 13237.
- 4 B. A. Pinaud, J. D. Benck, L. C. Seitz, A. J. Forman, Z. Chen, T. G. Deutsch, B. D. James, K. N. Baum, G. N. Baum, S. Ardo, H. Wang, E. Miller and T. F. Jaramillo, Energy Environ. Sci., 2013, 6, 1983–2002.
- 5 M. R. Shaner, H. A. Atwater, N. S. Lewis and E. W. McFarland, Energy Environ. Sci., 2016, 9, 2354–2371.
- 6 Y. Xiao, C. Feng, J. Fu, F. Wang, C. Li, V. F. Kunzelmann, C. M. Jiang, M. Nakabayashi, N. Shibata, I. D. Sharp, K. Domen and Y. Li, Nat. Catal., 2020, 3, 932–940.
- 7 Y. Pihosh, T. Minegishi, V. Nandal, T. Higashi, M. Katayama, T. Yamada, Y. Sasaki, K. Seki, Y. Suzuki, M. Nakabayashi, M. Sugiyama and K. Domen, Energy Environ. Sci., 2020, 13, 1519–1530.
- 8 Y. Kawase, T. Higashi, K. Domen and K. Takanabe, Adv. Energy Sustainability Res., 2021, 2, 2100023.
- 9 M. S. Prévot and K. Sivula, *J. Phys. Chem. C*, 2013, 117, 17879–17893.
- 10 K. T. Fountaine, H. J. Lewerenz and H. A. Atwater, Nat. Commun., 2016, 7, 13706.
- 11 H. Song, S. Luo, H. Huang, B. Deng and J. Ye, ACS Energy Lett., 2022, 7, 1043–1065.
- 12 S. Hu, C. Xiang, S. Haussener, A. D. Berger and N. S. Lewis, Energy Environ. Sci., 2013, 6, 2984–2993.
- 13 J. Brillet, J. H. Yum, M. Cornuz, T. Hisatomi, R. Solarska, J. Augustynski, M. Graetzel and K. Sivula, Nat. Photonics, 2012, 6, 824–828.
- 14 W. J. Lee, P. S. Shinde, G. H. Go and E. Ramasamy, Int. J. Hydrogen Energy, 2011, 36, 5262–5270.
- 15 Y. Pihosh, I. Turkevych, K. Mawatari, J. Uemura, Y. Kazoe, S. Kosar, K. Makita, T. Sugaya, T. Matsui, D. Fujita, M. Tosa, M. Kondo and T. Kitamori, Sci. Rep., 2015, 5, 11141.
- 16 F. F. Abdi, L. Han, A. H. M. Smets, M. Zeman, B. Dam and R. van de Krol, Nat. Commun., 2013, 4, 2195.
- 17 Y. Kuang, Q. Jia, G. Ma, T. Hisatomi, T. Minegishi, H. Nishiyama, M. Nakabayashi, N. Shibata, T. Yamada, A. Kudo and K. Domen, Nat. Energy, 2016, 2, 16191.
- 18 Y. S. Chen, J. S. Manser and P. V. Kamat, J. Am. Chem. Soc., 2015, 137, 974–981.
- 19 Y. Pihosh, J. Uemura, I. Turkevych, K. Mawatari, Y. Kazoe, A. Smirnova and T. Kitamori, Angew. Chem., Int. Ed., 2017, 56, 8130–8133.
- 20 D. Huang, K. Wang, L. Li, K. Feng, N. An, S. Ikeda, Y. Kuang, Y. Ng and F. Jiang, Energy Environ. Sci., 2021, 14, 1480–1489.
- 21 A. Duret and M. Grätzel, *J. Phys. Chem. B*, 2005, 109, 17184–17191.
- 22 J. W. Jang, C. Du, Y. Ye, Y. Lin, X. Yao, J. Thorne, E. Liu, G. McMahon, J. Zhu, A. Javey, J. Guo and D. Wang, Nat. Commun., 2015, 6, 7447.
- 23 K. Y. Yoon, J. Park, M. Jung, S. G. Ji, H. Lee, J. H. Seo, M. J. Kwak, S. Il Seok, J. H. Lee and J. H. Jang, Nat. Commun., 2021, 12, 4309.
- 24 B. A. Pinaud, P. C. K. Vesborg and T. F. Jaramillo, J. Phys. Chem. C, 2012, 116, 15918–15924.
- 25 V. Nandal, Y. Pihosh, T. Higashi, T. Minegishi, T. Yamada, K. Seki, M. Sugiyama and K. Domen, Energy Environ. Sci., 2021, 14, 4038–4047.
- 26 T. Higashi, H. Nishiyama, Y. Otsuka, Y. Kawase, Y. Sasaki, M. Nakabayashi, M. Katayama, T. Minegishi, N. Shibata, K. Takanabe, T. Yamada and K. Domen, ChemSusChem, 2020, 13, 1974–1978.
- 27 M. Kim, B. Lee, H. Ju, J. Y. Kim, J. Kim and S. W. Lee, Adv. Mater., 2019, 31, 1903316.
- 28 S. Lee, L. Ji, A. C. De Palma and E. T. Yu, Nat. Commun., 2021, 12, 3982.
- 29 R. Fan, S. Cheng, G. Huang, Y. Wang, Y. Zhang, S. Vanka, G. A. Botton, Z. Mi and M. Shen, J. Mater. Chem. A, 2019, 7, 2200–2209.
- 30 S. A. Lee, I. J. Park, J. W. Yang, J. Park, T. H. Lee, C. Kim, J. Moon, J. Y. Kim and H. W. Jang, Cell Reports Phys. Sci., 2020, 1, 100219.
- 31 J. H. Kim, H. E. Kim, J. H. Kim and J. S. Lee, J. Mater. Chem. A, 2020, 8, 9447–9482.
- 32 H. Kobayashi, N. Sato, M. Orita, Y. Kuang, H. Kaneko, T. Minegishi, T. Yamada and K. Domen, Energy Environ. Sci., 2018, 11, 3003–3009.
- 33 J. Luo, Z. Li, S. Nishiwaki, M. Schreier, M. T. Mayer, P. Cendula, Y. H. Lee, K. Fu, A. Cao, M. K. Nazeeruddin, Y. E. Romanyuk, S. Buecheler, S. D. Tilley, L. H. Wong, A. N. Tiwari and M. Grätzel, Adv. Energy Mater., 2015, 5, 1501520. **Faces Articles.** Published on 2022. Downloaded on 2022. Downloaded on 2022. Downloaded on 2022. Downloaded on 2022. This article is likensed under a method on 2022. Downloaded in the speed with the speed with the speed un
	- 34 H. Kaneko, T. Minegishi, M. Nakabayashi, N. Shibata, Y. Kuang, T. Yamada and K. Domen, Adv. Funct. Mater., 2016, 26, 4570–4577.
	- 35 S. K. Karuturi, H. Shen, A. Sharma, F. J. Beck, P. Varadhan, T. Duong, P. R. Narangari, D. Zhang, Y. Wan, J. H. He, H. H. Tan, C. Jagadish and K. Catchpole, Adv. Energy Mater., 2020, 10, 2000772.
	- 36 D. Xue, M. Kan, X. Qian and Y. Zhao, ACS Sustainable Chem. Eng., 2018, 6, 16228–16234.
	- 37 S. Wang, P. Chen, Y. Bai, J. H. Yun, G. Liu and L. Wang, Adv. Mater., 2018, 30, 1800486.
	- 38 D. Gurudayal, M. H. Sabba, L. H. Kumar, J. Wong, M. Barber, M. Grätzel and N. Mathews, Nano Lett., 2015, 15, 3833–3839.
	- 39 Gurudayal, R. A. John, P. P. Boix, C. Yi, C. Shi, M. C. Scott, S. A. Veldhuis, A. M. Minor, S. M. Zakeeruddin, L. H. Wong, M. Grätzel and N. Mathews, ChemSusChem, 2017, 10, 2449-2456.
	- 40 J. Park, K. Y. Yoon, T. Kim, H. Jang, M. J. Kwak, J. Y. Kim and J. H. Jang, Nano Energy, 2020, 76, 105089.
	- 41 E. Nurlaela, M. Nakabayashi, Y. Kobayashi, N. Shibata, T. Yamada and K. Domen, Sustain. Energy Fuels, 2020, 4, 2293–2300.
	- 42 W. J. Chun, A. Ishikawa, H. Fujisawa, T. Takata, J. N. Kondo, M. Hara, M. Kawai, Y. Matsumoto and K. Domen, J. Phys. Chem. B, 2003, 107, 1798–1803.
	- 43 G. Liu, S. Ye, P. Yan, F. Xiong, P. Fu, Z. Wang, Z. Chen, J. Shi and C. Li, Energy Environ. Sci., 2016, 9, 1327–1334.
	- 44 Z. Wang, Y. Inoue, T. Hisatomi, R. Ishikawa, Q. Wang, T. Takata, S. Chen, N. Shibata, Y. Ikuhara and K. Domen, Nat. Catal., 2018, 1, 756–763.
	- 45 Q. Wang, T. Hisatomi, S. S. K. Ma, Y. Li and K. Domen, Chem. Mater., 2014, 26, 4144–4150.
	- 46 Y. He, J. E. Thorne, C. H. Wu, P. Ma, C. Du, Q. Dong, J. Guo and D. Wang, Chem, 2016, 1, 640–655.
	- 47 M. Zhong, T. Hisatomi, Y. Sasaki, S. Suzuki, K. Teshima, M. Nakabayashi, N. Shibata, H. Nishiyama, M. Katayama, T. Yamada and K. Domen, Angew. Chem., Int. Ed., 2017, 56, 4739–4743.
	- 48 J. Fu, Z. Fan, M. Nakabayashi, H. Ju, N. Pastukhova, Y. Xiao, C. Feng, N. Shibata, K. Domen and Y. Li, Nat. Commun., 2022, 13, 729.
	- 49 J. Liu, W. Luo, K. Zhu, X. Wen, F. Xiu, J. Yuan, Z. Zou and W. Huang, RSC Adv., 2017, 7, 30650–30656.
	- 50 J. Seo, T. Takata, M. Nakabayashi, T. Hisatomi, N. Shibata, T. Minegishi and K. Domen, J. Am. Chem. Soc., 2015, 137, 12780–12783.
- 51 L. Pei, B. Lv, S. Wang, Z. Yu, S. Yan, R. Abe and Z. Zou, ACS Appl. Energy Mater., 2018, 1, 4150–4157.
- 52 D. Akagi, Y. Kageshima, Y. Hashizume, S. Aoi, Y. Sasaki, H. Kaneko, T. Higashi, T. Hisatomi, M. Katayama, T. Minegishi, S. Noda and K. Domen, ChemPhotoChem, 2019, 3, 521–524.
- 53 Y. W. Kim, S. Cha, I. Kwak, I. S. Kwon, K. Park, C. S. Jung, E. H. Cha and J. Park, ACS Appl. Mater. Interfaces, 2017, 9, 36715–36722.
- 54 Y. Pihosh, V. Nandal, T. Minegishi, M. Katayama, T. Yamada, K. Seki, M. Sugiyama and K. Domen, ACS Energy Lett., 2020, 5, 2492–2497.
- 55 M. Higashi, K. Domen and R. Abe, Energy Environ. Sci., 2011, 4, 4138–4147.
- 56 H. Hajibabaei, O. Zandi and T. W. Hamann, Chem. Sci., 2016, 7, 6760–6767.
- 57 T. Higashi, H. Nishiyama, Y. Suzuki, Y. Sasaki, T. Hisatomi, M. Katayama, T. Minegishi, K. Seki, T. Yamada and K. Domen, Angew. Chem., Int. Ed., 2019, 58, 2300–2304.
- 58 H. Hajibabaei, D. J. Little, A. Pandey, D. Wang, Z. Mi and T. W. Hamann, ACS Appl. Mater. Interfaces, 2019, 11, 15457–15466.
- 59 Y. Kawase, T. Higashi, M. Katayama, K. Domen and K. Takanabe, ACS Appl. Mater. Interfaces, 2021, 13, 16317–16325.
- 60 N. Kaiser, Appl. Opt., 2002, 41, 3053–3060.
- 61 O. Kluth, G. Schöpe, J. Hüpkes, C. Agashe, J. Müller and B. Rech, Thin Solid Films, 2003, 442, 80–85.
- 62 E. Nurlaela, M. Harb, S. del Gobbo, M. Vashishta and K. Takanabe, J. Solid State Chem., 2015, 229, 219–227.
- 63 W. Zhang, X. Jiang, Z. Dong, J. Wang, N. Zhang, J. Liu, G. R. Xu and L. Wang, Adv. Funct. Mater., 2021, 31, 2107181.
- 64 C. C. L. McCrory, S. Jung, J. C. Peters and T. F. Jaramillo, J. Am. Chem. Soc., 2013, 135, 16977–16987.
- 65 M. Liao, J. Feng, W. Luo, Z. Wang, J. Zhang, Z. Li, T. Yu and Z. Zou, Adv. Funct. Mater., 2012, 22, 3066–3074.
- 66 Z. Wang, Y. Qi, C. Ding, D. Fan, G. Liu, Y. Zhao and C. Li, Chem. Sci., 2016, 7, 4391–4399.
- 67 G. Liu, P. Fu, L. Zhou, P. Yan, C. Ding, J. Shi and C. Li, Chem. – Eur. J., 2015, 21, 9624–9628.
- 68 K. Obata and K. Takanabe, Angew. Chem., Int. Ed., 2018, 57, 1616–1620.
- 69 F. D. Speck, K. E. Dettelbach, R. S. Sherbo, D. A. Salvatore, A. Huang and C. P. Berlinguette, Chem, 2017, 2, 590–597.
- 70 S. Zou, M. S. Burke, M. G. Kast, J. Fan, N. Danilovic and S. W. Boettcher, Chem. Mater., 2015, 27, 8011–8020.
- 71 M. Bernardi, D. Vigil-Fowler, C. S. Ong, J. B. Neaton and S. G. Louie, Proc. Natl. Acad. Sci. U. S. A., 2015, 112, 5291–5296.
- 72 A. D. Wright, C. Verdi, R. L. Milot, G. E. Eperon, M. A. Pérez-Osorio, H. J. Snaith, F. Giustino, M. B. Johnston and L. M. Herz, Nat. Commun., 2016, 7, 11755.
- 73 M. Monti, S. X. Tao, M. Staniforth, A. Crocker, E. Griffin, A. Wijesekara, R. A. Hatton and J. Lloyd-Hughes, J. Phys. Chem. C, 2018, 122, 20669–20675.
- 74 V. Nandal, R. Shoji, H. Matsuzaki, A. Furube, L. Lin, T. Hisatomi, M. Kaneko, K. Yamashita, K. Domen and K. Seki, Nat. Commun., 2021, 12, 7055.
- 75 V. Nandal and P. R. Nair, J. Phys. Chem. C, 2018, 122, 27935–27940.
- 76 V. Nandal, Y. Suzuki, H. Kobayashi, K. Domen and K. Seki, J. Mater. Chem. A, 2020, 8, 9194–9201.
- 77 S. Agarwal, V. Nandal, H. Yadav and K. Kumar, J. Appl. Phys., 2021, 129, 203101.
- 78 V. Nandal, S. Agarwal and P. R. Nair, Phys. Chem. Chem. Phys., 2021, 23, 24421–24427.